

December 2010 UniFET

FDD7N25LZ N-Channel MOSFET 250V, 6.2A, 0.55Ω

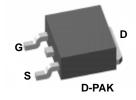
Features

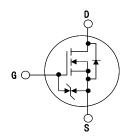
- $R_{DS(on)} = 0.43\Omega$ (Typ.)@ $V_{GS} = 10V$, $I_D = 3.1A$
- Low Gate Charge (Typ.12nC)
- Low C_{rss} (Typ. 8pF)
- · Fast Switching
- 100% Avalanche Tested
- Improved dv/dt Capability
- · RoHS Compliant

Description

These N-Channel enhancement mode power field effect transis tors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advance technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switching mode power supplies and active power factor correction.





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted*

Symbol	Parameter			Ratings	Units	
V _{DSS}	Drain to Source Voltage			250	V	
V _{GSS}	Gate to Source Voltage			±20	V	
	Drain Current	-Continuous (T _C = 25°C)		6.2	^	
ID	Drain Current	-Continuous (T _C = 100°C)		3.7	Α	
I _{DM}	Drain Current	- Pulsed	25	Α		
E _{AS}	Single Pulsed Avalanche Energy (N		(Note 2)	115	mJ	
I _{AR}	Avalanche Current		(Note 1)	5.5	Α	
E _{AR}	Repetitive Avalanche Energy		(Note 1)	5.6	mJ	
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	10	V/ns	
D	Dower Dissipation	(T _C = 25°C)		56	W	
P_{D}	Power Dissipation	- Derate above 25°C		0.45	W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C	
T _L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C	

Thermal Characteristics

Symbol	Parameter	Тур	Max	Units	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	-	2.2	90.444	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	- 110 °C/W		G/ VV	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD7N25LZ	FDD7N25LZ	D-PAK	380mm	16mm	2500

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	teristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu A$, $V_{GS} = 0V$, $T_C = 25^{\circ}C$	250	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu\text{A}$, Referenced to 25°C	-	0.25	-	V/°C
	Zero Gate Voltage Drain Current	V _{DS} = 250V, V _{GS} = 0V	-	-	1	
IDSS	Zero Gate voltage Drain Current	$V_{DS} = 200V, T_{C} = 125^{\circ}C$	-	-	10	μΑ
I _{GSSF}	Gate to Body Leakage Current, Forward	V _{GS} = 20V, V _{DS} = 0V	-	-	10	μА
I _{GSSR}	Gate to Body Leakage Current, Reverse	$V_{GS} = -20V, V_{DS} = 0V$	-	-	-10	μΑ

On Characteristics

V _{GS(th)}	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250\mu A$	1.0	-	2.0	V
P	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 3.1A$	-	0.43	0.55	Ω
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 5V, I_D = 3.1A$	-	0.45	0.57	22
9 _{FS}	Forward Transconductance	$V_{DS} = 20V, I_D = 3.1A$ (Note 4)	-	7	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 05V V 0V	-	480	635	pF
C _{oss}	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V$ 	-	65	85	pF
C _{rss}	Reverse Transfer Capacitance	1 - 11/11/2	-	8	12	pF
Q _{g(tot)}	Total Gate Charge at 10V		-	12	16	nC
Q _{gs}	Gate to Source Gate Charge	$V_{DS} = 250 V I_{D} = 6.2 A$	-	1.5	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	V _{GS} = 10V (Note 4, 5)	-	4	-	nC

Switching Characteristics

t _{d(on)}	Turn-On Delay Time			10	30	ns
t _r		$V_{DD} = 250V, I_{D} = 6.2A$	-	15	40	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10V, R_G = 25\Omega$	-	75	160	ns
t _f	Turn-Off Fall Time	(Note 4, 5)	-	30	70	ns

Drain-Source Diode Characteristics

Is	Maximum Continuous Drain to Source Diode Forward Current				-	5.5	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current			-	-	20	Α
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{SD} = 6.2A$		-	-	1.4	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0V, I_{SD} = 6.2A$		-	130	-	ns
Q _{rr}	Reverse Recovery Charge	, 163 01, 30 0.2.1		-	μС		

Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 6mH, I $_{AS}$ = 6.2A, V $_{DD}$ = 50V, R $_{G}$ = 25 Ω , Starting T $_{J}$ = 25 $^{\circ}$ C
- 3. I $_{SD} \leq$ 6.2A, di/dt \leq 200A/µs, V $_{DD} \leq$ BV $_{DSS},$ Starting T $_{J}$ = 25°C
- 4. Pulse Test: Pulse Width $\leq 300~\mu\text{s},$ Duty cycle $\leq 2.0\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

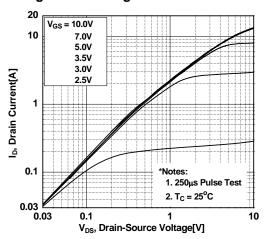


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

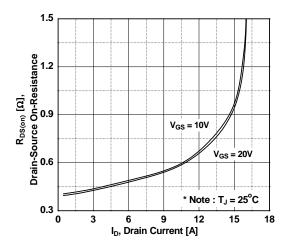


Figure 5. Capacitance Characteristics

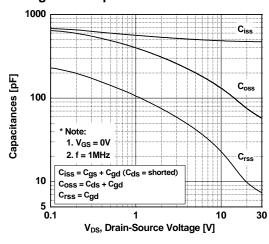


Figure 2. Transfer Characteristics

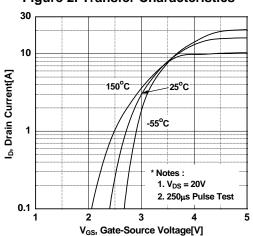


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

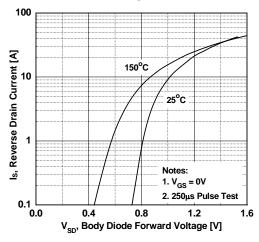
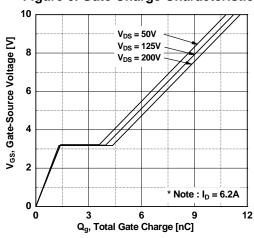
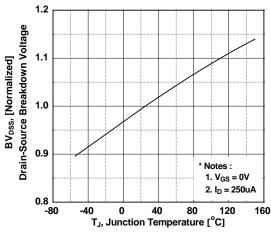


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature



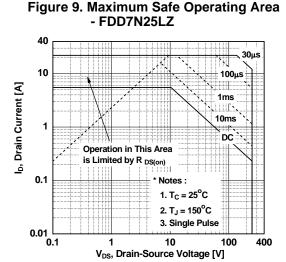


Figure 8. On-Resistance Variation vs. Temperature

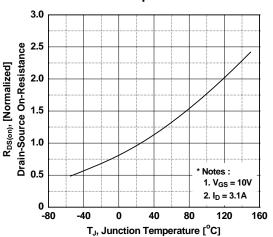


Figure 10. Maximum Drain Current vs. Case Temperature

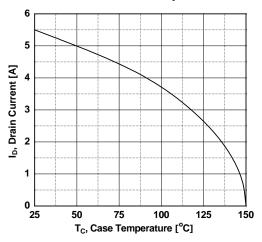
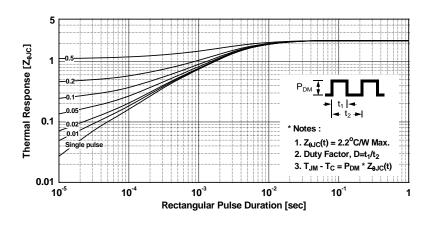
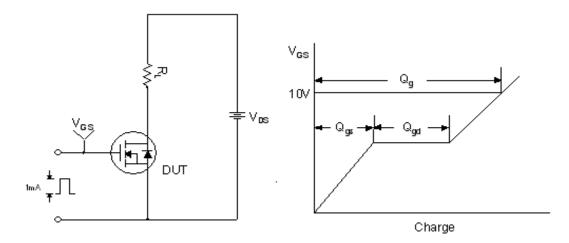


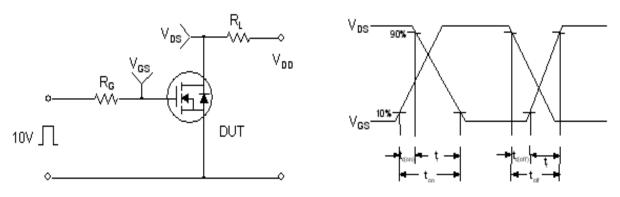
Figure 11. Transient Thermal Response Curve - FDD7N25LZ



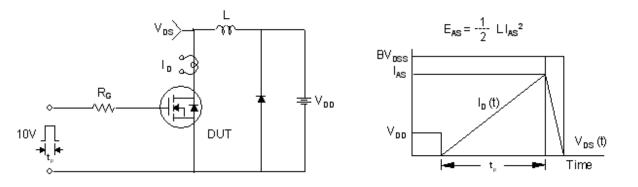
Gate Charge Test Circuit & Waveform



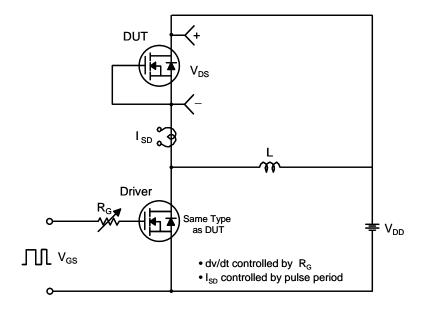
Resistive Switching Test Circuit & Waveforms

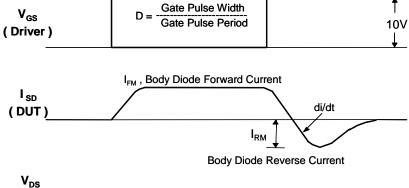


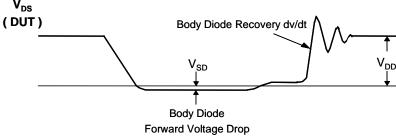
Unclamped Inductive Switching Test Circuit & Waveforms



Peak Diode Recovery dv/dt Test Circuit & Waveforms

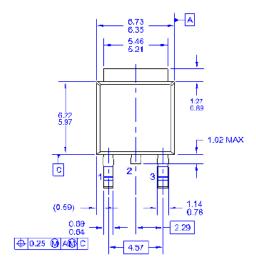


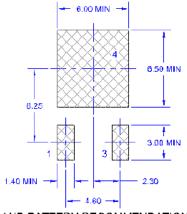




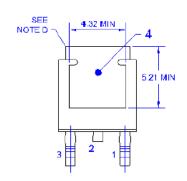
Mechanical Dimensions

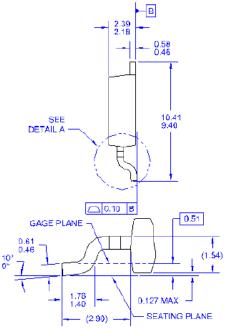
D-PAK





LAND PATTERN RECOMMENDATION





- NOTES: UNLESS OTHERWISE SPECIFIED

 A) THIS PACKAGE CONFORMS TO JEDEC, TO-252.
 ISSUE C, VARIATION AA.
 B) ALL DINENSIONS ARE IN MILLIMETERS.
 C) DINENSIONINB AND TOLERANCING PER ASME Y1-15N-1894.
 D) HEAT SINK TOP EDGE COULD BE IN CHAMFERED CORNERS OR EDGE FROTRUSICM.
 E) PRESENCE OF TRIMMED CENTER LEAD
 IS OPTIONAL
 F) DIMENSIONS ARE EXCLUSSIVE OF BURSS, WOLD FLASH AND HE BAR EX HRUSIONS.
 D) LAND PATTERN RECOMENDATION IS BASED ON IPC7351A STD TO22071003X29-3N.
 H) DRAWING NUMBER AND REVISION: WKT-TO252A03REVB

Dimensions in Millimeters





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